

$\Lambda_b^0 \rightarrow \Lambda_c^+ \pi^-$ Lifetime Update

R. Mumford J. Pursley, M. Martin, M. Schmidt, S. Behari, P. Maksimovic

Johns Hopkins University

D. Litvinsev

FNAL

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Talk Outline

- SVT Efficiency Function Redux
- Smoothed SVT Eff. Histogram
- Pursing a Consistent Signal MC Fit

SVT Efficiency Function Review

SVT eff. fn. accounts for bias introduced by TTT and selection cuts.
Technique used is described in cdfnote 7386

SVT efficiency histogram defined by:

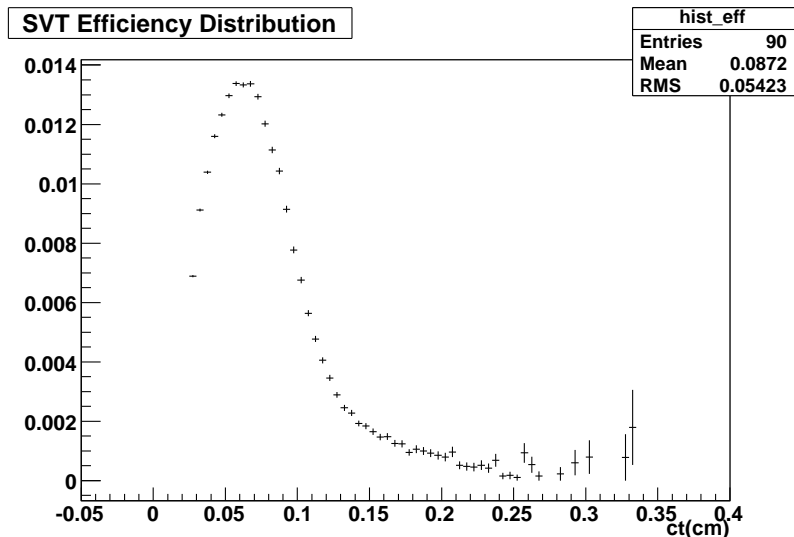
$$\epsilon(ct) = \frac{Histo^{TTT}(ct)}{\sum_i \exp(ct_i, c\tau^{MC}) \otimes Gauss(\sigma_{ct}^i)}$$

that is fit to get “efficiency function”;

$$\epsilon_{TTT}(ct) = \sum_{i=1}^{i=3} N_i \cdot (x - \beta_i)^2 \cdot e^{-x/\tau_i} \cdot (x > \beta_i)$$

This parameterization does not describe our SVT shape very well.
Unstable lifetime fit results.

Lifetime Fit Review



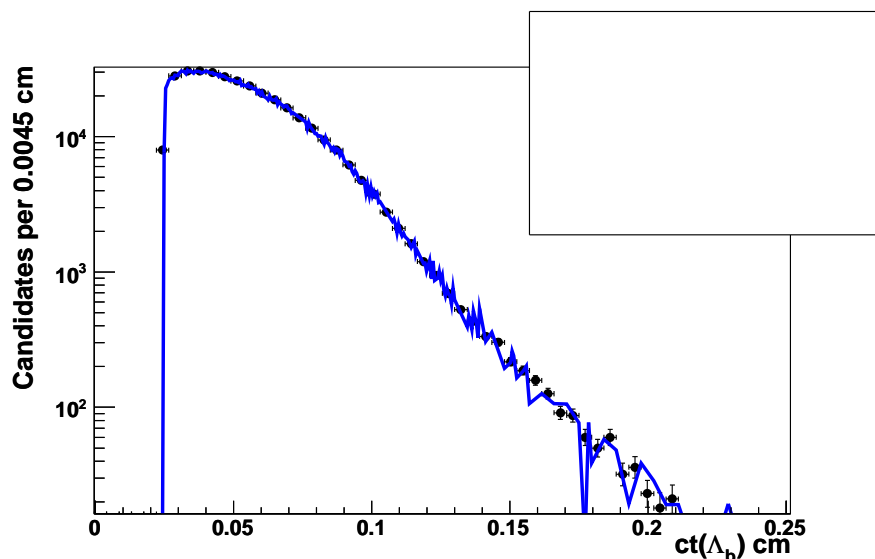
Instead of fitting, we tried using the raw Histogram

bins	Λ_b^0 lifetime
45	$369.6 \pm 1.0 \mu m$
90	$361.6 \pm 1.0 \mu m$
180	$361.5 \pm 1.0 \mu m$

ct Result depends on binning

Lack of continuous shape also gives poor lifetime fit projection

Planned to create a smoothed histogram to approximate a continuous SVT eff. function



Smoothed SVT Efficiency Histogram

SVT efficiency histogram originally defined by:

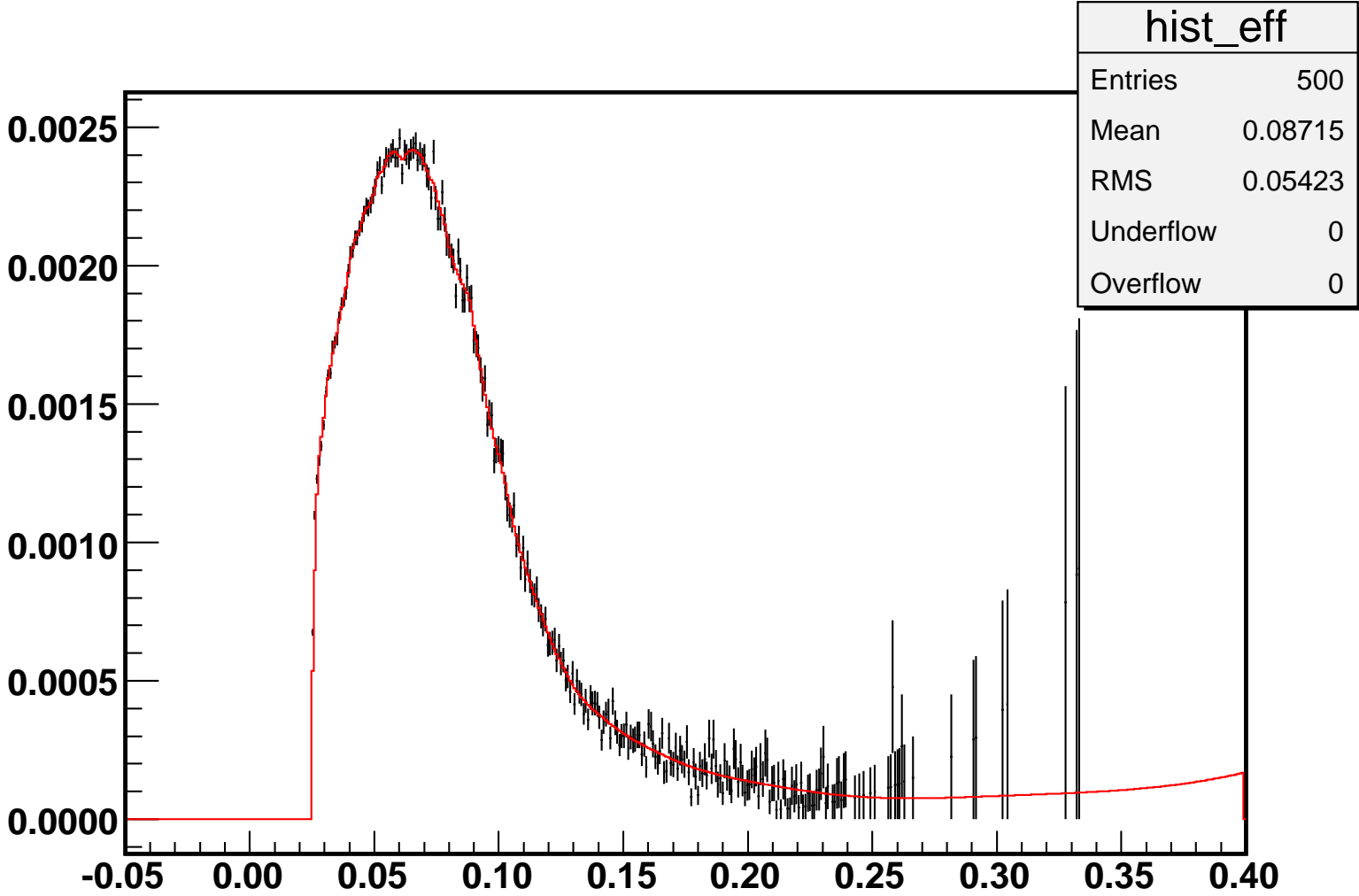
$$\epsilon(ct) = \frac{Histo^{TTT}(ct)}{\sum_i \exp(ct_i, c\tau^{MC}) \otimes Gauss(\sigma_{ct}^i)}$$

We replace the numerator with a smoothed distribution

$$\epsilon(ct) = \frac{RooKeysPdf_{histo}^{TTT}(ct)}{\sum_i \exp(ct_i, c\tau^{MC}) \otimes Gauss(\sigma_{ct}^i)}$$

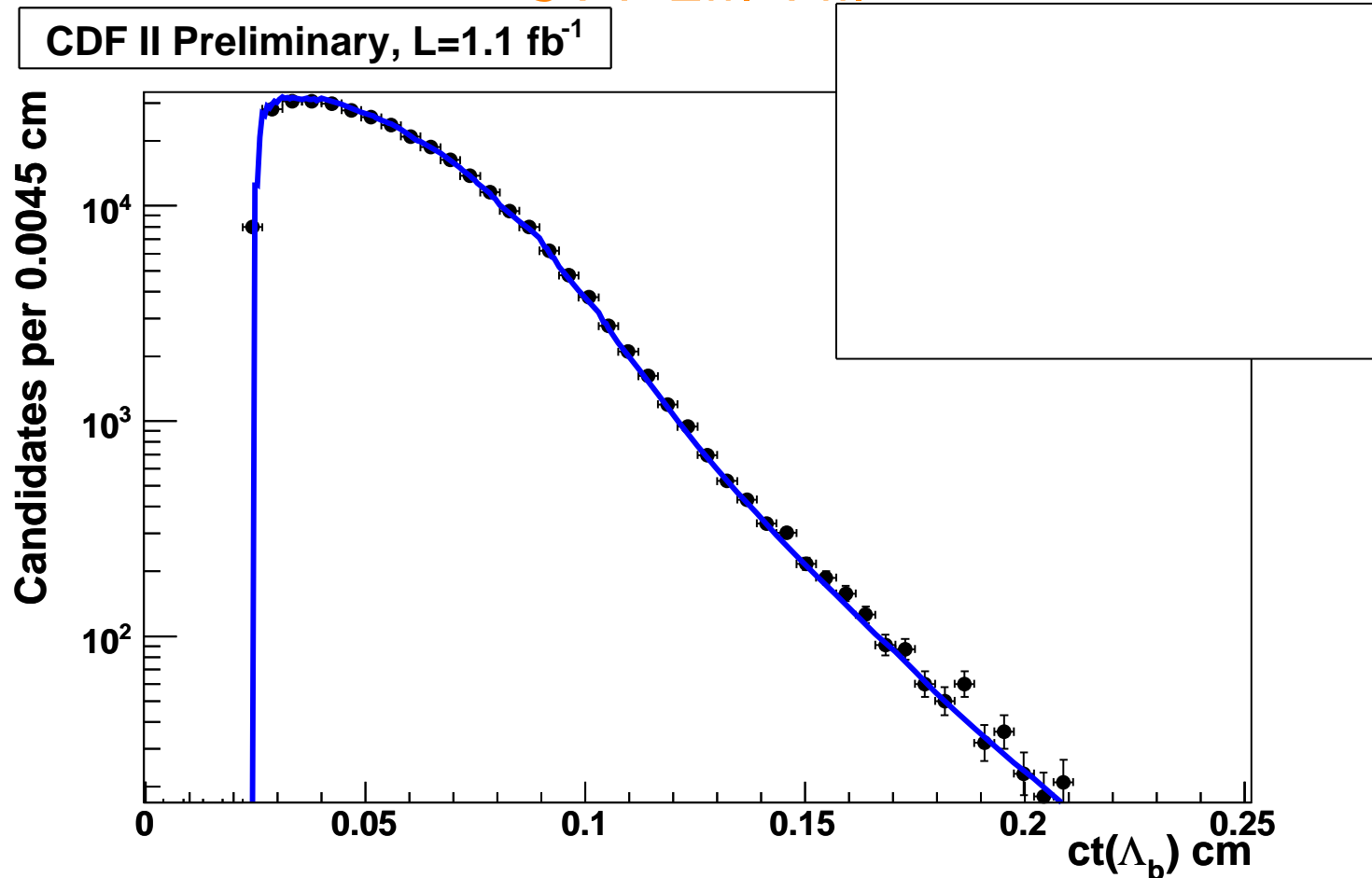
RooKeysPdf makes a smoothed distribution from the $ct(\Lambda_b^0)$ data.
This “function” is used to fill a finely binned histogram which is then used as the
numerator

SVT Efficiency Smoothed Histogram II



Lifetime Fit and Projection

MC fit (input $ct(\Lambda_b^0) = 369\mu m$): ct projection looks good w/ RooKeys
SVT Eff. Fn.



However, Λ_b^0 Lifetime fit result is $\sim 10\mu m$ low ($358.9 \pm 1\mu m$)!

Circular Sanity Check

$$f(ct) = \frac{1}{c\tau} e^{-ct'/\tau} \otimes R(ct, ct') \epsilon_{TTT}(ct)$$

$$\frac{f(ct)}{\epsilon_{TTT}(ct)} = \frac{1}{c\tau} e^{-ct'/\tau} \otimes R(ct, ct')$$

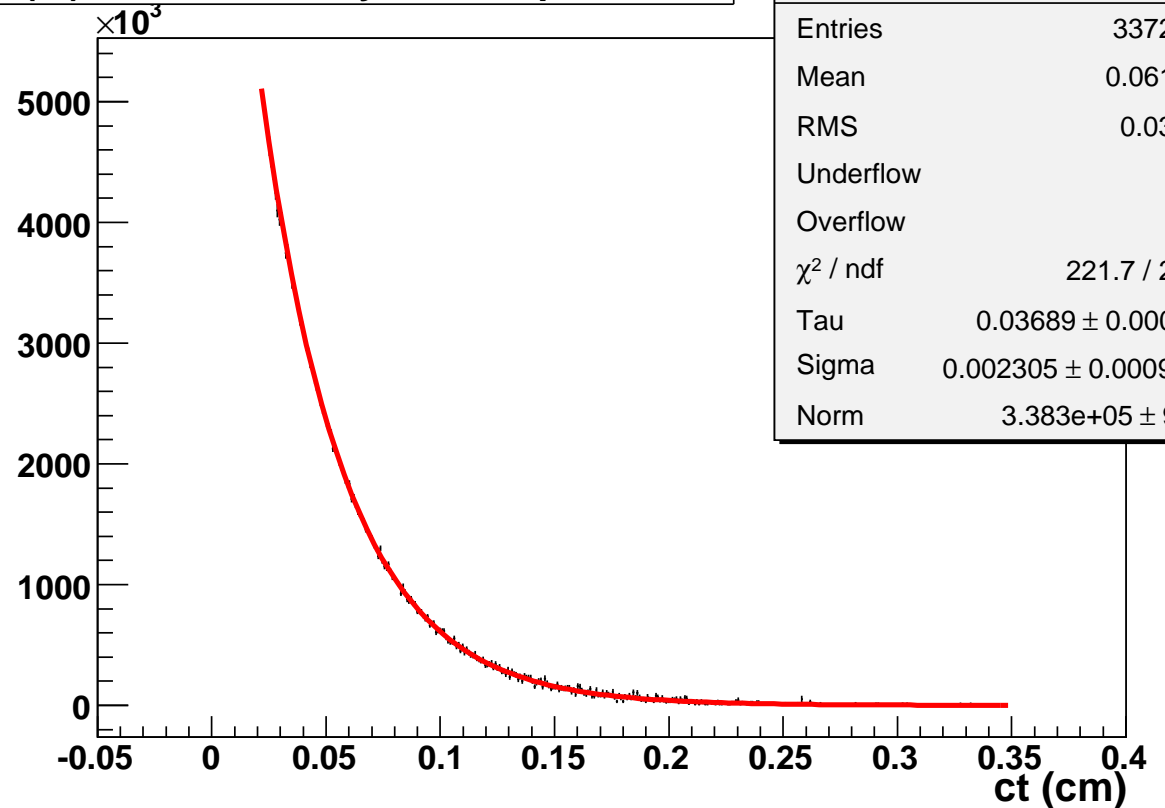
← Expected Λ_b^0 lifetime distribution

Fit Monte Carlo using same ExpoGauss code as our standard fit framework \Rightarrow

$ct(\Lambda_b^0)$ and σ_{ct} from fit agree well w/ MC input lifetime ($ct(\Lambda_b^0) = 369\mu m$) and lifetime error.

No $10\mu m$ offset here...

f(ct) / SVT efficiency fit w/ ExpoGauss



Conclusion and Outlook

- Have developed a method for dealing with SVT efficiency instability.
- SVT efficiency function issues are solved.
- Lifetime fit projection also looks good.
- Now hunting down sources of $\sim 10\mu m$ offset in the fitted lifetime of our MC sample.
 - Problem is suspected in our fit framework.
- Once the issue is solved, we'll...
 - move ahead w/ fit in data.
 - recalculate the systematics.
 - update the documentation (cdfnote 8578).